

Vishay Siliconix

N-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	$R_{DS(on)}(\Omega)$ $I_D(A)^{a, g}$ Q_g			
20	0.0042 at V _{GS} = 10 V	35 ^g	13.2 nC		
	0.0058 at V _{GS} = 4.5 V	35 ^g	13.2110		

FEATURES

POL

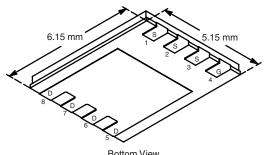
- Halogen-free
- TrenchFET® Power MOSFET
- 100 % R_g Tested

APPLICATIONS

• High Current DC/DC

100 % Avalanche Tested



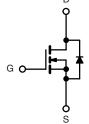


PowerPAK® SO-8

Bottom View

Ordering Information: SiR496DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

- Low-Side Switch



N-Channel MOSFET

Parameter		Symbol	Limit	Uni
Drain-Source Voltage		V _{DS}	20	v
Gate-Source Voltage		V_{GS}	± 20	
	T _C = 25 °C		35 ^g	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	35 ^g	
Continuous Diam Guitein (1) = 150 C)	T _A = 25 °C	'D	25.7 ^{b, c}	
	T _A = 70 °C		20.5 ^{b, c}	A
Pulsed Drain Current		I _{DM}	70	
Continuous Source-Drain Diode Current	T _C = 25 °C	lo	35 ^g	
	T _A = 25 °C	ls —	4.5 ^{b, c}	
Single Pulse Avalanche Current L = 0.		I _{AS}	20	
Single Pulse Avalanche Energy	L = 0.111111	E _{AS}	20	mJ
Maximum Power Dissipation	T _C = 25 °C		27.7	
	T _C = 70 °C	P _D	17.7	w
	T _A = 25 °C	' Б	5.0 ^{b, c}	
	T _A = 70 °C		3.2 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) ^{d, e}			260	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	20	25	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	3.4	4.5] 5/**	

- a. Based on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 70 °C/W.
- g. Package limited.

SiR496DP

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				1			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			20		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 4.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V			1		
		V _{DS} = 20 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 20 A		0.0033	0.0042	Ω	
		V _{GS} = 4.5 V, I _D = 10 A		0.0046	0.0058		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 20 A		50		S	
Dynamic ^b	'			1			
Input Capacitance	C _{iss}			1570			
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		555		pF	
Reverse Transfer Capacitance	C _{rss}			195			
·		V _{DS} = 10 V, V _{GS} = 10 V, I _D = 10 A		28	42	nC	
Total Gate Charge	Q_g	Q_g		13.2	20		
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		3.8			
Gate-Drain Charge	Q _{gd}			4.0			
Gate Resistance	R _g	f = 1 MHz	0.2	0.7	1.4	Ω	
Turn-On Delay Time	t _{d(on)}			21	35	ns	
Rise Time	t _r	V_{DD} = 10 V, R_L = 1.0 Ω		13	26		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 10 A, V_{GEN} = 10 V, R_g = 1 Ω		29	55		
Fall Time	t _f			17	30		
Turn-On Delay Time	t _{d(on)}			10	20		
Rise Time	t _r	V_{DD} = 10 V, R_L = 1 Ω		8	16		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 10 A, V_{GEN} = 4.5 V, R_g = 1 Ω		22	40		
Fall Time	t _f			8	16		
Drain-Source Body Diode Characteristi	cs			•			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			35	A	
Pulse Diode Forward Current ^a	I _{SM}				70		
Body Diode Voltage	V_{SD}	I _S = 3 A		0.75	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			22	44	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, dl/dt = 100 A/μs, T _{.I} = 25 °C		10	20	nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ ul/ul} = 100 \text{ A/}\mu\text{s}, I_J = 25 ^{\circ}\text{C}$		11		ns	
Reverse Recovery Rise Time	t _b	1		11			

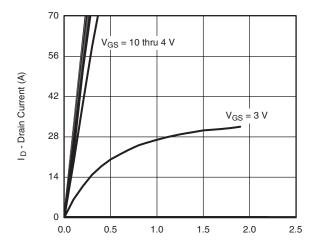
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



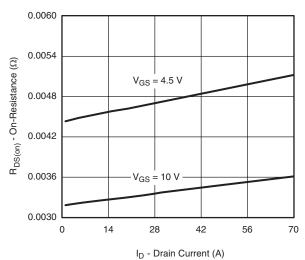
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

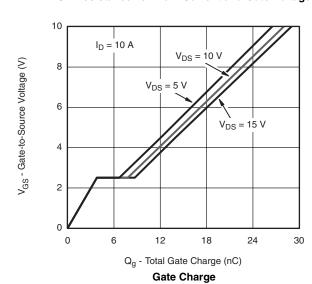


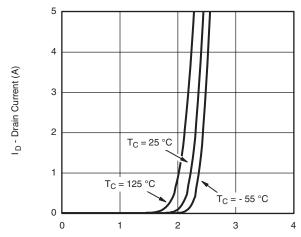
 V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics



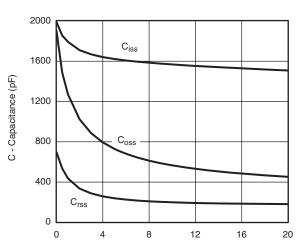
On-Resistance vs. Drain Current and Gate Voltage





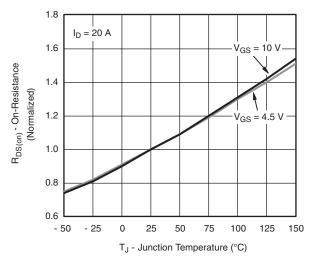
V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics



 V_{DS} - Drain-to-Source Voltage (V)

Capacitance



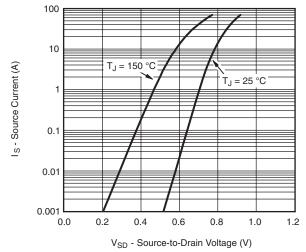
On-Resistance vs. Junction Temperature

SiR496DP

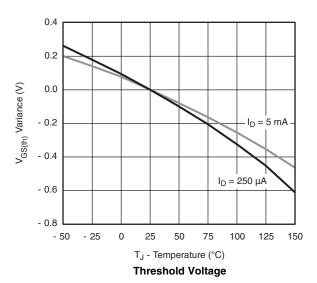
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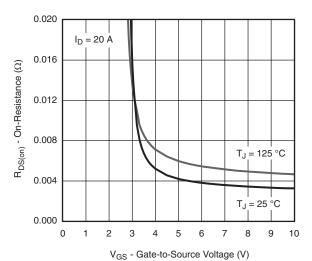
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

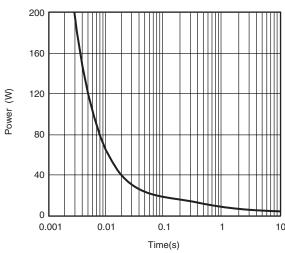


Source-Drain Diode Forward Voltage

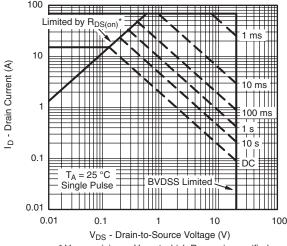




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



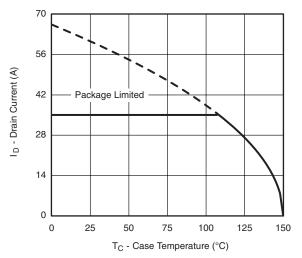
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

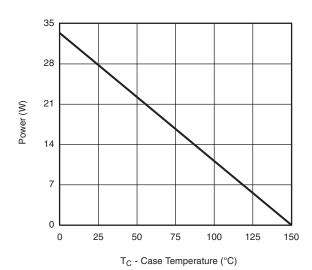


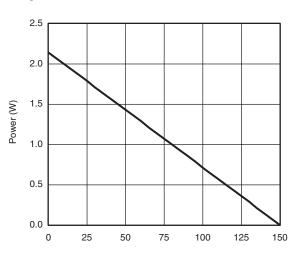
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*





 T_A - Ambient Temperature (°C) Power, Junction-to-Ambient

Power, Junction-to-Case

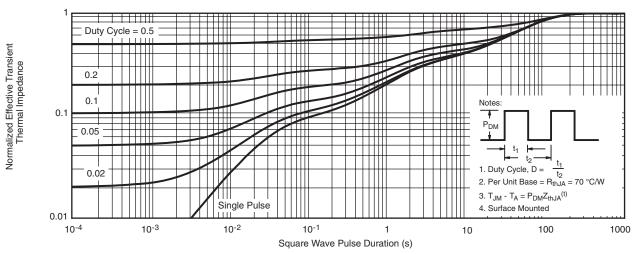
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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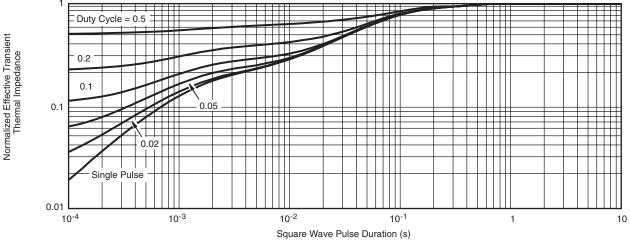
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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